

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/521,943 SUEHIRO ET AL.	
		Examiner	Art Unit David J. Makiya	2885 Page 1 of 1

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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